Issue Classification

Application/Control No.	Applicant(s)/Patent Under Reexamination
10507180	DE BETHUNE ET AL.
Examiner	**Art Unit**
JENNIFER Y CHO	1621

ORIGINAL		INTERNATIONAL CLASSIFICATION	
CLASS	SUBCLASS	CLAIMED	NON-CLAIMED
562	430	C 0 7 C 315 / 00 (2006.01.01)	
CROSS REFERENCE(S)		C 0 7 C 317 / 00 (2006.01.01)	
		C 0 7 C 321 / 00 (2006.01.01)	
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)	C 0 7 C 323 / 00 (2006.01.01)	
562	432	C 0 7 C 381 / 00 (2006.01.01)	

/JENNIFER Y CHO/ 5/6/08 (Assistant Examiner) (Date)		**Total Claims Allowed:** 4	
/Yvonne Eyler/ 5/16/08 (Primary Examiner) (Date)		O.G. Print Claim(s) 20	O.G. Print Figure none